

ILL

Manon Letiche

RADNEXT 1st Annual Meeting – 8-9 June 2022

<https://indico.cern.ch/e/radnext-2022>

**RAD
NEXT**

The logo for RADNEXT features the word "RAD" in a light blue, sans-serif font above the word "NEXT" in a dark blue, sans-serif font. The letter "X" in "NEXT" is stylized with a circular graphic element in the center, resembling a particle detector or a lens.

1. Completed TA campaigns

N/A

2. Scheduled TA campaigns

N/A

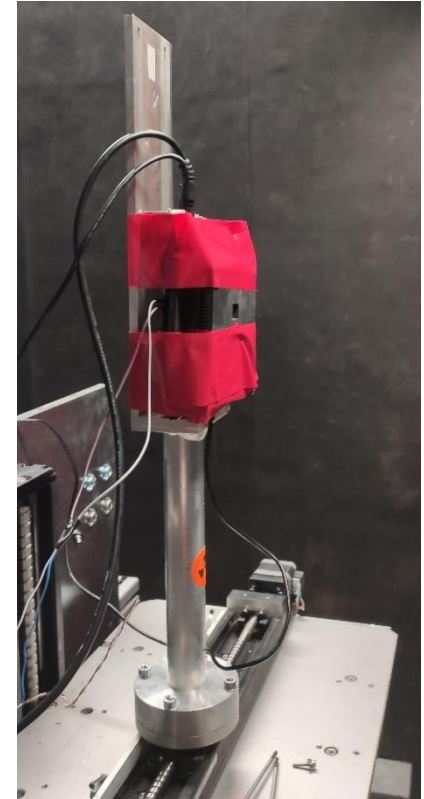
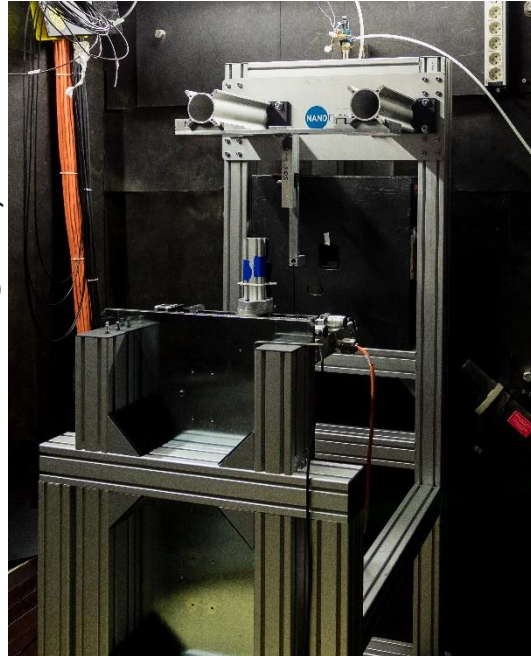
3. Accepted and assigned TA campaigns, to be scheduled

N/A

TENIS: Thermal and Epi-thermal Neutron Irradiation Station

- **Beam characteristics**
 - Beam with a fission spectrum: large component of thermal neutrons
 - Flux_{thermal-equivalent}: 2,4 n.cm⁻².s⁻¹ estimated by Au foils activation at the sample position for a reactor power of 55MW
 - Adjustable beam size from 1x1 mm² to 50 x 50 mm²
- A calculated flux of gamma coming from the reactor, **compatible with TID test**
 - $\Phi\gamma = 7.5 \times 10^8 \text{ } \gamma/\text{cm}^2/\text{s}$
 - Dose Rate = 18 Gy/h (1,8 KRad/h)
 - Maximum dose rate reachable using Cd: 115 Gy/h (11,5 kRad/h)

@P. Jayet CEA LETI



TIMA set-up

4. TA time already awarded VS Total facility TA quota

- ILL HFR reactor shutdown: October 2021 – “January” 2023
- Very few proposals for thermal neutrons have been received
 - Is it due to our large communication about the shutdown?
 - Is it due to a lack of communication about thermal neutrons applications?
- 100h through TA at TENIS facility to be granted during RADNEXT project

Ground floor and avionic applications

Effects of thermal neutron radiation on a hardware-implemented machine learning algorithm

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ARTICLE INFO

ABSTRACT

Keywords:
Radiation effects
Machine learning algorithms

Hardware-implemented machine learning algorithms in critical applications. This

Contribution of Thermal Neutrons to Soft Error Rate

Cécile Weulersse, Sabine Houssany, Nicolas Guibbaud, Jaime Segura-Ruiz, Jérôme Beaucour,

High Energy and Thermal Neutrons Sensitivity of Google Tensor Processing Units

Rubens Luiz Rech Junior^{*}, Sujit Malde¹, Carlo Cazzaniga¹, Maria Kastriotou¹, Manon Letiche², Christopher Frost¹, and Paolo Rech^{3,5}

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Abstract— Boron-10 and logic devices before fabrication process neutrons with high energy contributes to the soft error rate of the facility, the thermal

1412

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Thermal Neutron-Induced SEUs in the LHC Accelerator Environment

Matteo Cecchetto¹, Student Member, IEEE, Rubén García Alía¹, Member, IEEE, Frédéric Wrobel¹, Member, IEEE, Maris Tali¹, Member, IEEE, Oliver Stein, Giuseppe Lerner¹,

Kacper Bilko¹, Luigi Esposito, Cristiano
Matteo Brucoli¹, Associate

Neutron-induced effects on a self-refresh DRAM^{†*}

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Effects of Thermal Neutron Irradiation on a Self-Refresh DRAM

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ARTICLE INFO

ABSTRACT

Keywords:
Neutron
Radiation
Self-refresh
DRAM
SEU
Stuck bits

The field of radiation effects in electronics research includes unknowns for technical development. In this study, static and dynamic test methods were used to refresh DRAM under neutron irradiation. The neutron-induced effects were evaluated through event cross sections, soft-error rate, and bitmaps evaluations, leading to the identification of temporary stuck cells, single-bit upsets, and block errors. Block errors were observed with a dependency in the addressing order, leading to up to two thousand faulty

5. Approach for user (financial) support

N/A

6. Overall feedback about TA workflow

This 6th point can be covered in 1 slide.

Thanks for your attention!



Image Source: CERN